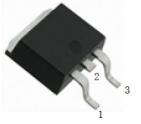
WTR03P055LS-HAF

P-Channel Enhancement Mode MOSFET

Features

- Low On-Resistance
- Low Miller Charge
- Halogen and Antimony Free(HAF), RoHS compliant

Gate Source



1.Gate 2.Drain 3.Source TO-252 Plastic Package

Applications

- Motor/Body Load Control
- Load Switch

Key Parameters

	-	
Parameter	Value	Unit
-BV _{DSS}	30	V
R _{DS(ON)} Max	5.5 @ -V _{GS} = 10 V	mΩ
	7 @ -V _{GS} = 4.5 V	11122
-V _{GS(th)} typ	1.3	V
Q _g typ	146 @ -V _{GS} = 10 V	nC

Absolute Maximum Ratings (at Ta = 25°C unless otherwise specified)

Parameter		Symbol	Value	Unit
Drain-Source Voltage		-V _{DS}	30	V
Gate-Source Voltage		V _{GS}	± 20	V
Drain Current	T _c = 25°C T _c = 100°C	-I _D	100 63	А
Peak Drain Current, Pulsed 1)		-I _{DM}	400	А
Single-Pulse Avalanche Current		-l _{AS}	60.9	А
Single-Pulse Avalanche Energy 2)		Eas	185.4	mJ
Power Dissipation	T _c = 25°C	P _D	78.8	W
Operating Junction and Storage Temperat	ure Range	TJ, T _{stg}	- 55 to + 150	°C

Thermal Characteristics

Parameter	Symbol	Max.	Unit
Thermal Resistance from Junction to Case	Rejc	1.5	°C/W
Thermal Resistance from Junction to Ambient 3)	R _{θJA}	32	°C/W

¹⁾ Pulse Test: Pulse Width ≤ 100 μs, Duty Cycle ≤ 2%, Repetitive rating, pulse width limited by junction temperature $T_{J(MAX)}$ = 150°C.



 $^{^{2)}}$ Limited by T_{J(MAX)}, starting T_J = 25 °C, L = 0.1 mH, R_g = 25 Ω , -I_{AS} = 60.9 A, V_{GS} = 10 V.

³⁾ Device mounted on FR-4 substrate PC board, 2oz copper, with 1-inch square copper plate in still air.

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Characteristics at Ta = 25°C unless otherwise specified

Parameter	Symbol	Min.	Тур.	Max.	Unit
STATIC PARAMETERS	•		•		
Drain-Source Breakdown Voltage at -I _D = 250 μA	-BV _{DSS}	30	-	-	V
Drain-Source Leakage Current at -V _{DS} = 30 V	-I _{DSS}	-	-	1	μΑ
Gate Leakage Current at V _{GS} = ± 20 V	lgss	-	-	± 100	nA
Gate-Source Threshold Voltage at V_{DS} = V_{GS} , $-I_D$ = 250 μ A	-V _{GS(th)}	1	-	2.3	V
Drain-Source On-State Resistance at -V _{GS} = 10 V, -I _D = 18 A at -V _{GS} = 4.5 V, -I _D = 10 A	R _{DS(on)}	-	3.7	5.5 7	mΩ
DYNAMIC PARAMETERS					
Forward Transconductance at -V _{DS} = 10 V, -I _D = 5 A	g FS	-	26.3	-	S
Gate Resistance at $V_{GS} = 0 \text{ V}$, $V_{DS} = 0 \text{ V}$, $f = 1 \text{ MHz}$	Rg	-	1.7	-	Ω
Input Capacitance at $-V_{DS} = 15 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 1 \text{ MHz}$	Ciss	-	8000	-	pF
Output Capacitance at $-V_{DS} = 15 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 1 \text{ MHz}$	Coss	-	802	-	pF
Reverse Transfer Capacitance at $-V_{DS} = 15 \text{ V}$, $V_{GS} = 0 \text{ V}$, $f = 1 \text{ MHz}$	Crss	-	630	-	pF
Total Gate Charge at -V _{DS} = 15 V, -V _{GS} = 10 V, -I _D = 18 A at -V _{DS} = 15 V, -V _{GS} = 4.5 V, -I _D = 18 A	Qg	- -	146 70	- -	nC
Gate-Source Charge at - V_{DS} = 15 V, - V_{GS} = 10 V, - I_{D} = 18 A	Qgs	-	25	-	nC
Gate-Drain Charge at $-V_{DS} = 15 \text{ V}$, $-V_{GS} = 10 \text{ V}$, $-I_D = 18 \text{ A}$	Q_{gd}	-	26	-	nC
Turn-On Delay Time at $-V_{DD}$ = 15 V, $-V_{GS}$ = 10 V, $-I_D$ = 18 A, R_G = 6 Ω	t _{d(on)}	-	69	-	ns
Turn-On Rise Time at -V _{DD} = 15 V, -V _{GS} = 10 V, -I _D = 18 A, R _G = 6 Ω	t _r	-	56	-	ns
Turn-Off Delay Time at -V _{DD} = 15 V, -V _{GS} = 10 V, -I _D = 18 A, R _G = 6 Ω	t _{d(off)}	-	68	-	ns
Turn-Off Fall Time at -V _{DD} = 15 V, -V _{GS} = 10 V, -I _D = 18 A, R _G = 6 Ω	t _f	-	16	-	ns
Body-Diode PARAMETERS			1	i	
Drain-Source Diode Forward Voltage at $-I_S = 1 A$, $V_{GS} = 0 V$	-V _{SD}	-	-	1.2	V
Body-Diode Continuous Current	-I _S	-	-	100	Α
Body-Diode Continuous Current, Pulsed	-I _{SM}	-	-	400	Α
Body Diode Reverse Recovery Time at -I _S = 18 A, di/dt = 100 A / μs	t _{rr}	-	25.4	-	ns
Body Diode Reverse Recovery Charge at -I _s = 18 A, di/dt = 100 A / μs	Qrr	-	20	-	nC



Electrical Characteristics Curves

Fig. 1 Typical Output Characteristics

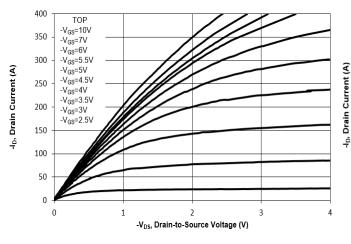


Fig. 2 Typical Transfer Characteristics

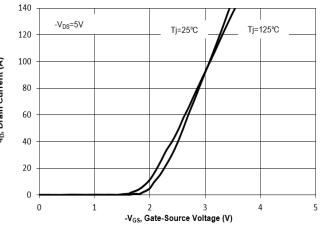


Fig. 3 on-Resistance vs. Drain Current

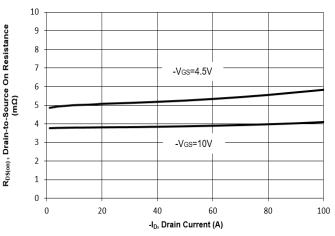


Fig. 4 on-Resistance vs. Gate to Source Voltage

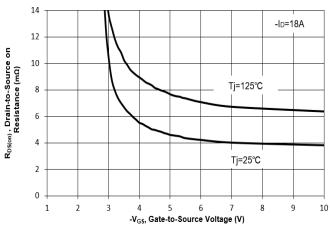


Fig. 5 on-Resistance vs.T_j

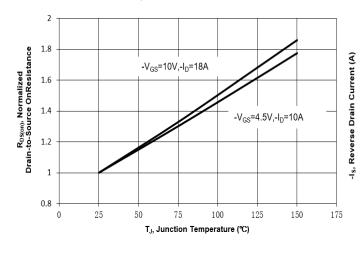
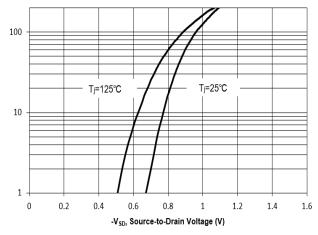


Fig. 6 Typical Body-Diode Forward Characteristics





Electrical Characteristics Curves

Fig. 7 Typical Junction Capacitance

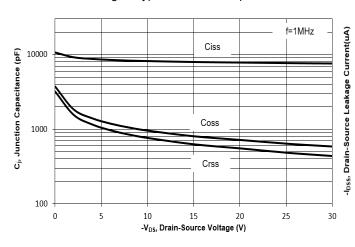


Fig. 8 Drain-Source Leakage Current vs. T_j

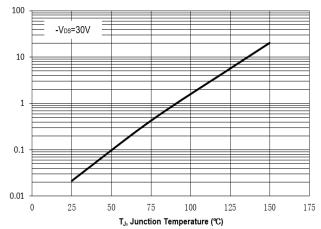


Fig. 9 V_{(BR)DSS} vs. Junction Temperature

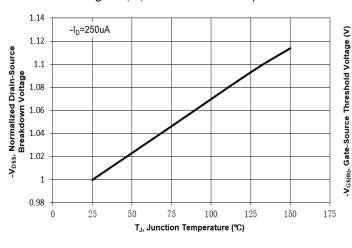


Fig. 10 Gate Threshold Variation vs. T_i

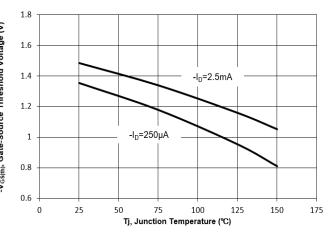


Fig. 11 Gate Charge

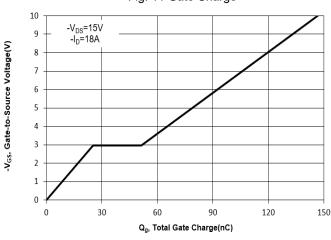
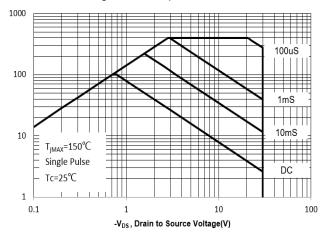


Fig. 12 Safe Operation Area



-I_D, Drain Current(A)

Electrical Characteristics Curves

0.00001

0.000001

0.0001

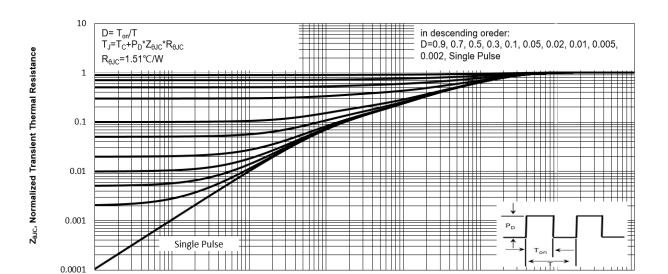


Fig. 13 Normalized Maximum Transient Thermal Impedance(z_eJc)

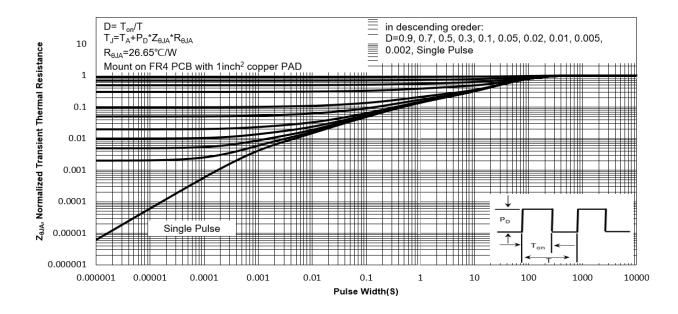


Pulse Width(S)

0.01

0.1

1

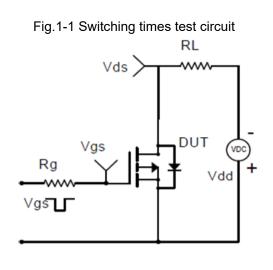




10

WTR03P055LS-HAF

Test Circuits



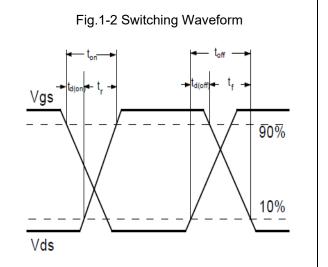


Fig.2-1 Gate charge test circuit

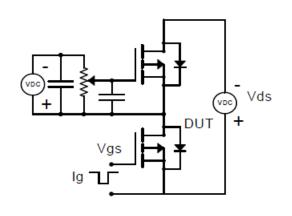


Fig.2-2 Gate charge waveform

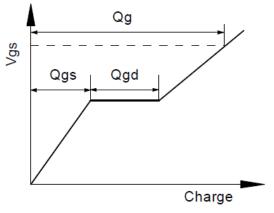


Fig.3-1 Avalanche test circuit

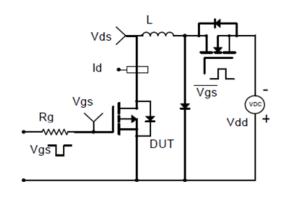
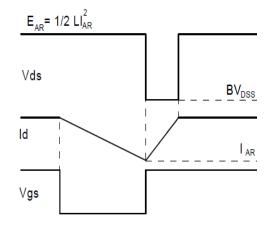


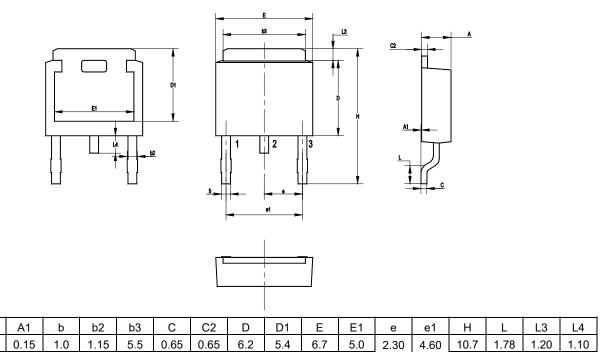
Fig.3-2 Avalanche waveform





Package Outline (Dimensions in mm)

TO-252



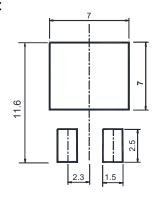
Recommended Soldering Footprint

0.5

0.65

4.9

0



5.6

5.0

6.1

4.6

TYP.

TYP.

1.40

0.85

0.51

0.4

Packing information

UNIT

mm

2.5

2.1

i doming iiiio						
Package Tape Width		Pitch		Reel Size		Per Reel Packing Quantity
((mm) mm	mm	inch	mm	inch	rei Neel Fackling Qualitity
TO-252	16	8 ± 0.1	0.315 ± 0.004	330	13	2,500

Marking information

" TR03P055LS " = Part No.

" ***** " = Date Code Marking

Font type: Arial



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